

## Single N-Channel MOSFET

### DESCRIPTION

SMC4734 is the N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior, fast switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

### PART NUMBER INFORMATION

**SMC 4734 PA - TR G**  
 a b c d e

- a : Company name.
- b : Product Serial number.
- c : Package code PA:DFN5X6A-8
- d : Handling code TR:Tape&Reel
- e : Green produce code G:RoHS Compliant

### FEATURES

**$V_{DS} = 30V, I_D = 60A$**

$R_{DS(ON)} = 4.5m\Omega(Typ.)@V_{GS}=10V$   
 $R_{DS(ON)} = 5.6m\Omega(Typ.)@V_{GS}=4.5V$

- ◆ Low Gate Charge
- ◆ 100% UIS and Rg tested
- ◆ High power and current handling capability

### APPLICATIONS

- ◆ Wireless Charging
- ◆ DC/DC Converters



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-Source Voltage	30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current	$T_C=25^\circ C$	60
		$T_C=100^\circ C$	38
$I_{DM}$	Pulsed Drain Current <sup>A</sup>	200	A
$I_D$	Continuous Drain Current	$T_A=25^\circ C$	21
		$T_A=70^\circ C$	17
$P_D$	Power Dissipation <sup>B</sup>	$T_A=25^\circ C$	4.2
		$T_A=70^\circ C$	2.7
$I_{AS}$	Avalanche Current <sup>A</sup>	30	A
$E_{AS}$	Single Pulse Avalanche energy $L=0.1mH$ <sup>AF</sup>	45	mJ
$P_D$	Power Dissipation <sup>C</sup>	$T_C=25^\circ C$	33
		$T_C=100^\circ C$	13.2
$T_J$	Operation Junction Temperature	-55/150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55/150	$^\circ C$

### THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>B</sup>	$t \leq 10s$	30	$^\circ C/W$
	Thermal Resistance Junction to Ambient <sup>BD</sup>	Steady-State	50	
$R_{\theta JC}$	Thermal Resistance Junction to Case		3.8	

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ Unless otherwise noted)

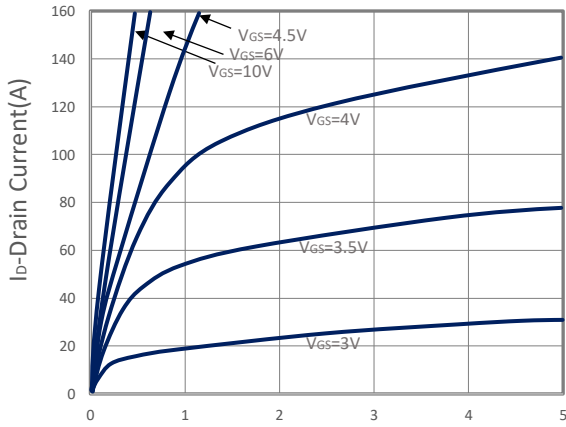
Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Parameters</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	1.6	2.5	V
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$			$\pm 100$	nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V, T_J=25^\circ\text{C}$			1	$\mu A$
		$V_{DS}=24V, V_{GS}=0V, T_J=75^\circ\text{C}$			10	
$R_{DS(ON)}$	Drain-source On-Resistance <sup>E</sup>	$V_{GS}=10V, I_D=21A$ $V_{GS}=4.5V, I_D=15A$		4.5 5.6	6 7	$m\Omega$
$G_{fs}$	Forward Transconductance	$V_{DS}=10V, I_D=10A$		60		S
<b>Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage <sup>E</sup>	$I_S=1A, V_{GS}=0V$		0.7	1.0	V
$I_S$	Continuous Source Current				30	A
$t_{rr}$	Reverse Recovery Time	$I_S=10A, di/dt=100A/\mu s$		22		ns
$Q_{rr}$	Reverse Recovery Charge			14		nC
<b>Dynamic and Switching Parameters</b>						
$Q_g$	Total Gate Charge (10V)	$V_{DS}=15V, V_{GS}=10V, I_D=10A$		24.7	33.4	nC
$Q_g$	Total Gate Charge (4.5V)			12	16.8	
$Q_{gs}$	Gate-Source Charge			2.5	3.5	
$Q_{gd}$	Gate-Drain Charge			7.4	10.4	
$C_{iss}$	Input Capacitance	$V_{DS}=15V, V_{GS}=0V, f=1\text{MHz}$		1210		pF
$C_{oss}$	Output Capacitance			220		
$C_{rss}$	Reverse Transfer Capacitance			198		
$R_g$	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1\text{MHz}$		2		$\Omega$
$t_{d(on)}$	Turn-On Time <sup>E</sup>	$V_{DD}=15V, V_{GEN}=10V,$ $R_G=3\Omega, I_D=1A$		8.5	16	ns
$t_r$				16.2	31	
$t_{d(off)}$	Turn-Off Time <sup>E</sup>			30	57	
$t_f$				10.2	19	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

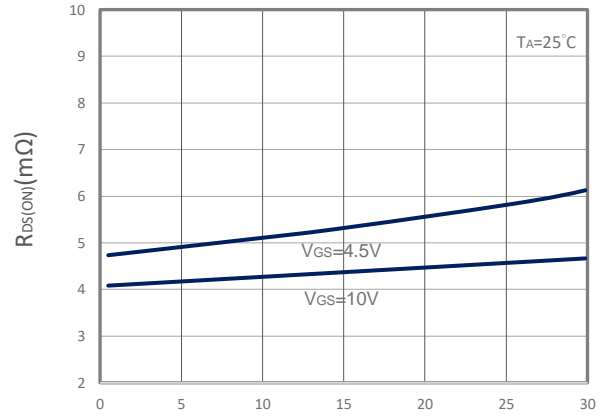
- A. Pulsed width limited by maximum junction temperature,  $T_{J(MAX)}=150^\circ\text{C}$ .
- B. Measure the value in a still air environment at  $T_A=25^\circ\text{C}$ , using an installation mounted on a 1 in2 FR-4 board, maximum junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ .
- C. Using junction-to-case thermal resistance, dissipation limit in the case of additional heat.
- D.  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance ( $R_{\theta JC}$ ) is more useful in additional heat sinking is used.
- E. The pulse test width is  $\leq 300\mu s$  and the duty cycle  $\leq 2\%$ .
- F. The EAS data shows Maximum, tested and pulse width limited by maximum.

The products and product specifications contained herein are subject to change without notice to improve performance characteristics. Consult us, or our representatives before use, to confirm that the information in this datasheet is up to date. We assume no responsibility for any infringement of patents, patent rights, or other rights arising from the use of any information and circuitry in this datasheet.

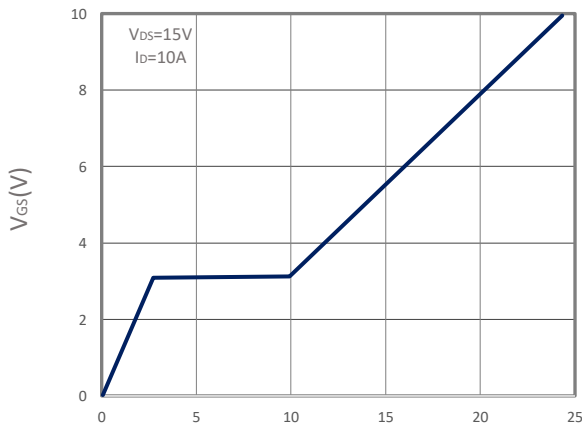
## TYPICAL CHARACTERISTICS



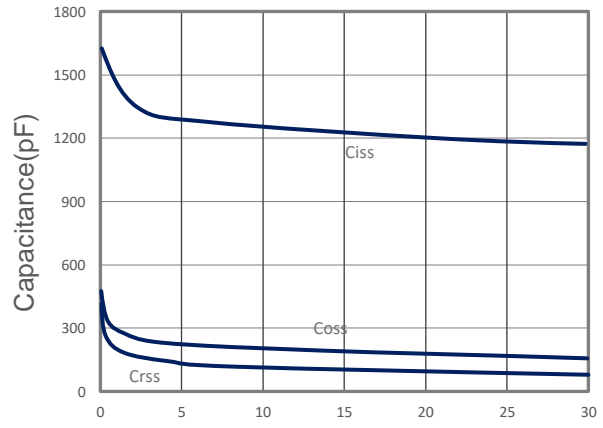
V<sub>DS</sub>-Drain Source Voltage (V)  
**Output Characteristics**



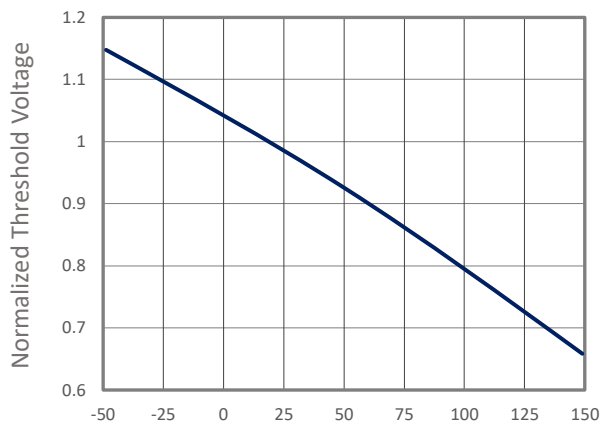
Id-Drain Current (A)  
**Drain-Source On Resistance**



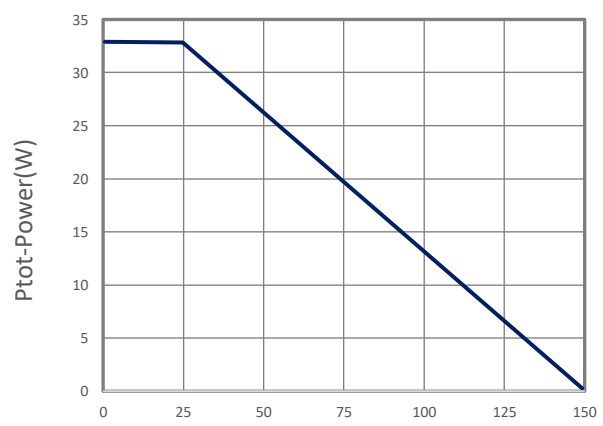
Qg-Gate Charge (nC)  
**Gate Charge**



V<sub>DS</sub>-Drain Source Voltage (V)  
**Capacitance**

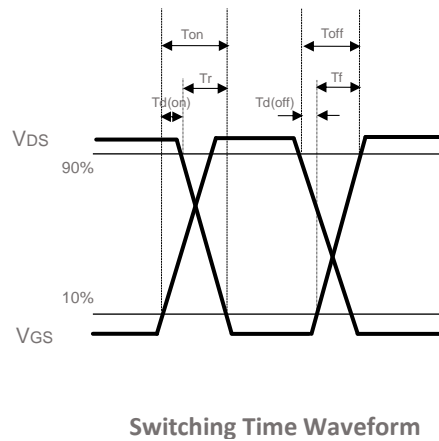
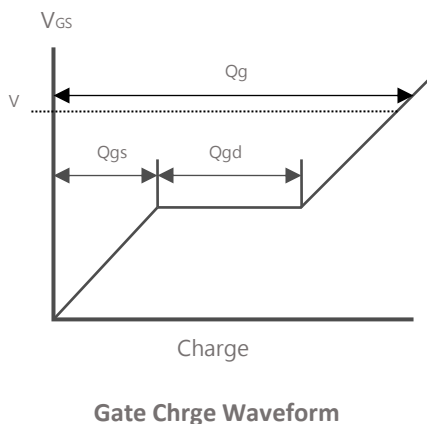
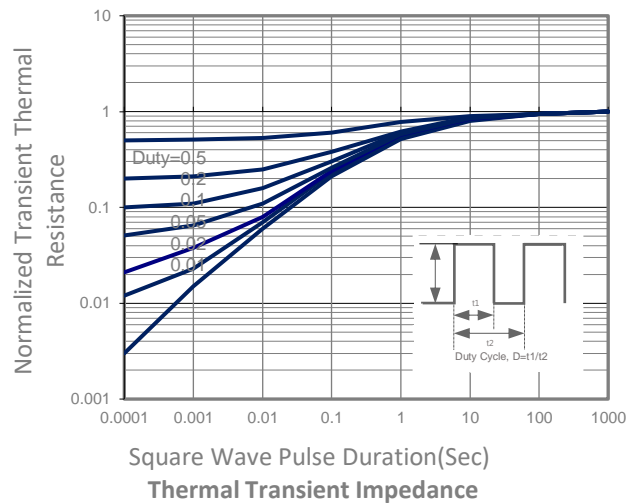
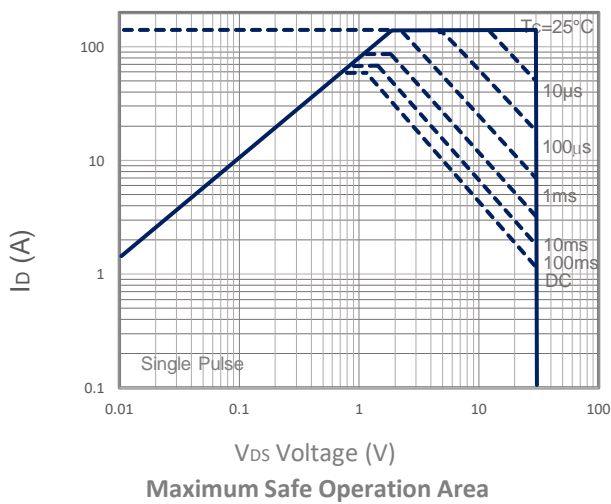
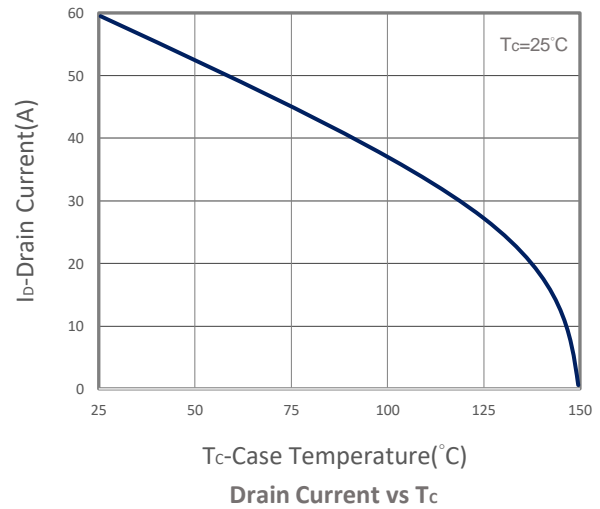
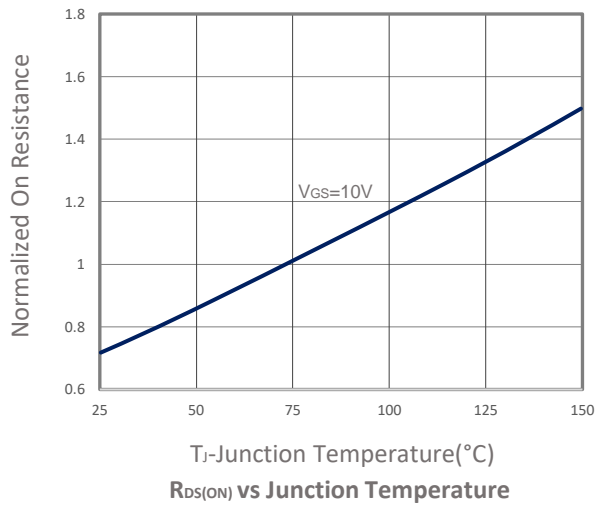


T<sub>J</sub>-Junction Temperature (°C)  
**Gate Threshold Voltage**

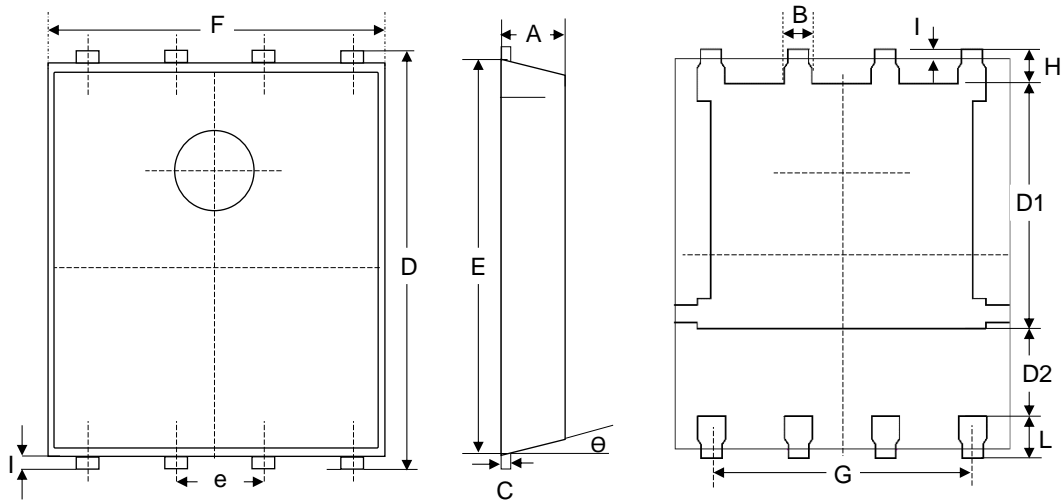


T<sub>J</sub>-Junction Temperature (°C)  
**Power Dissipation**

## TYPICAL CHARACTERISTICS



## DFN5X6A PACKAGE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.100	0.035	0.043
B	0.330	0.510	0.013	0.020
C	0.200	0.300	0.008	0.012
D	5.900	6.100	0.232	0.240
D1	3.380	3.780	0.133	0.149
D2	1.100		0.043	
E	5.700	5.800	0.224	0.228
e	1.270BSC.		1.270BSC.	
F	4.800	5.000	0.189	0.197
G	0.361	0.396	0.014	0.016
H	0.410	0.610	0.016	0.024
I	0.060	0.200	0.002	0.008
L	0.510	0.710	0.020	0.028
θ	0°	12°	0°	12°